

**Notice of References Cited**

Application/Control No.

09/810,195

Applicant(s)/Patent Under  
Reexamination  
SEKINE ET AL.

Examiner

Charles R Craver

Art Unit

2682

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0006778 A1	01-2002	Sekine et al.	455/318
	B	US-5,801,590 A	09-1998	Kashima et al.	331/68
	C	US-5,661,441 A	08-1997	Morino et al.	331/67
	D	US-4,922,211 A	05-1990	Otremba et al.	331/68
	E	US-4,484,162 A	11-1984	Kamada et al.	333/219
	F	US-4,079,341 A	03-1978	Linn et al.	331/96
	G	US-4,008,446 A	02-1977	Hirai, Kenji	331/96
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 59194518 A	11-1984	Japan	TAKAHASHI et al.	H03B 05/18
	O	JP 58178607 A	10-1983	Japan	MIZUMURA et al.	H03B 05/18
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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